Notice of References Cited 10/635,810 Reexamination SIMON ET AL. Examiner Derek L Dupuis Reexamination SIMON ET AL. Page 1 of 1

Application/Control No.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,307,987 B1	10-2001	Wang et al.	385/31
*	В	US-6,832,861 B2	12-2004	Kragl, Hans	385/88
*	С	US-5,129,032	07-1992	Kawai et al.	385/76
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

TOTAL							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
*	Z	GB 2168165 A	06-1986	United Kingdom	EMBREY, DEREK MORRIS	G02B 05/14	
	0						
	Р						
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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